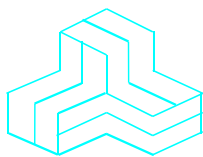


ENGINEERING TEST REPORT



Nix Mini
Model: NIXMINI001
FCC ID: 2AMKINIXMINI001

Applicant:

Nix Sensor Ltd
175 Longwood Rd S, Suite 408A
Hamilton, Ontario
Canada L8S 1N8

In Accordance With

Federal Communications Commission (FCC)
Part 15, Subpart C, Section 15.247
Digital Modulation Systems (DTS) Operating in 2400 – 2483.5 MHz Band

UltraTech's File No.: 17NIX004_FCC15C247

This Test report is Issued under the Authority of
Tri M. Luu
Vice President of Engineering
UltraTech Group of Labs

Date: July 14, 2017

Report Prepared by: Dan Huynh

Tested by: Hung Trinh

Issued Date: July 14, 2017

Test Dates: May 23, June 9 - 10, 2017

- *The results in this Test Report apply only to the sample(s) tested, and the sample tested is randomly selected.*
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AT-1945



SL2-IN-E-1119R



Korea
KCC-RRR
CA2049

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EXHIBIT 1. INTRODUCTION

1.1. SCOPE

Reference:	FCC Part 15, Subpart C, Section 15.247
Title:	Code of Federal Regulations (CFR), Title 47 – Telecommunication, Part 15 – Radio Frequency Devices
Purpose of Test:	Equipment Certification for Digital Modulation Systems (DTS) Operating Under §15.247
Test Procedures:	▪ ANSI C63.4 ▪ ANSI C63.10 ▪ FCC KDB Publication No. 558074 D01 DTS Meas Guidance v04
Environmental Classification:	[] Commercial, industrial or business environment [x] Residential environment

1.2. RELATED SUBMITTAL(S)/GRANT(S)

None.

1.3. NORMATIVE REFERENCES

Publication	Year	Title
47 CFR Parts 0-19	2017	Code of Federal Regulations (CFR), Title 47 – Telecommunication
ANSI C63.4	2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 KHz to 40 GHz
ANSI C63.10	2013	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices
FCC, KDB Publication No. 558074 D01 DTS Meas Guidance v04	2017	GUIDANCE FOR PERFORMING COMPLIANCE MEASUREMENTS ON DIGITAL TRANSMISSION SYSTEMS (DTS) OPERATING UNDER SECTION 15.247

EXHIBIT 2. PERFORMANCE ASSESSMENT

2.1. CLIENT INFORMATION

APPLICANT	
Name:	Nix Sensor Ltd
Address:	175 Longwood Rd S, Suite 408A Hamilton, Ontario Canada L8S 1N8
Contact Person:	Mr. Michael Bot Phone #: 905 518 6363 Fax #: n/a Email Address: mike@nixsensor.com

MANUFACTURER	
Name:	Nix Sensor Ltd
Address:	175 Longwood Rd S, Suite 408A Hamilton, Ontario Canada L8S 1N8
Contact Person:	Mr. Michael Bot Phone #: 905 518 6363 Fax #: n/a Email Address: mike@nixsensor.com

2.2. EQUIPMENT UNDER TEST (EUT) INFORMATION

The following information (with the exception of the Date of Receipt) has been supplied by the applicant.

Brand Name:	Nix Sensor Ltd
Product Name:	Nix Mini
Model Name or Number:	NIXMINI001
Serial Number:	Test Sample
Type of Equipment:	Digital Transmission System (DTS)
Input Power Supply Type:	Lithium polymer battery
Primary User Functions of EUT:	High resolution, wireless, portable color sensor. Color scans are initiated with phone/tablet.

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2.3. EUT'S TECHNICAL SPECIFICATIONS

Transmitter	
Equipment Type:	Portable
Intended Operating Environment:	Residential environment
Power Supply Requirement:	3.7 VDC
RF Output Power Rating:	3.30 dBm conducted power
Operating Frequency Range:	2402 - 2480 MHz
RF Output Impedance:	50 Ω
Duty Cycle:	Continuous
Modulation Type:	GFSK
Antenna Connector Types:	Integral chip antenna

2.4. ASSOCIATED ANTENNA DESCRIPTIONS

Manufacturer:	Johanson Technology
Type:	Chip
Model:	2450AT42A100
Frequency Range:	2.400GHz – 2.500GHz
Gain (dBi):	0 dBi

2.5. LIST OF EUT'S PORTS

Port Number	EUT's Port Description	Number of Identical Ports	Connector Type	Cable Type (Shielded/Non-shielded)
1	Charging port	1	USB Micro	USB Micro cable – shielded or unshielded

2.6. ANCILLARY EQUIPMENT

The EUT was tested while connected to the following representative configuration of ancillary equipment necessary to exercise the ports during tests:

Ancillary Equipment # 1	
Description:	USB Adapter
Brand name:	Apple
Model Name or Number:	A1385
Serial Number:	--
Connected to UUT's Port:	USB Micro

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EXHIBIT 3. EUT OPERATING CONDITIONS AND CONFIGURATIONS DURING TESTS

3.1. CLIMATE TEST CONDITIONS

The climate conditions of the test environment are as follows:

Temperature:	21 to 23 °C
Humidity:	45 to 58%
Pressure:	102 kPa
Power Input Source:	3.7 VDC

3.2. OPERATIONAL TEST CONDITIONS & ARRANGEMENT FOR TESTS

Operating Modes:	The transmitter was operated in a continuous transmission mode with the carrier modulated as specified in the Test Data.
Special Test Software:	Test software provided by the Applicant to operate the EUT at each channel frequency continuously and in the range of typical modes of operation.
Special Hardware Used:	N/A
Transmitter Test Antenna:	The EUT is tested with the antenna fitted in a manner typical of normal intended use as integral antenna equipment as described with the test results.

Transmitter Test Signals	
Frequency Band(s):	2402 - 2480 MHz
Frequency(ies) Tested:	2402 MHz, 2440 MHz, 2480 MHz
RF Power Output: (measured maximum output power at antenna terminals)	3.30 dBm Peak
Normal Test Modulation:	GFSK
Modulating Signal Source:	Internal

EXHIBIT 4. SUMMARY OF TEST RESULTS

4.1. LOCATION OF TESTS

All of the measurements described in this report were performed at Ultratech Group of Labs located in the city of Oakville, Province of Ontario, Canada.

- AC Power Line Conducted Emissions were performed in UltraTech's shielded room, 24'(L) by 16'(W) by 8'(H).
- Radiated Emissions were performed at the Ultratech's 3-10 TDK Semi-Anechoic Chamber situated in the Town of Oakville, province of Ontario. This test site been calibrated in accordance with ANSI C63.4, and found to be in compliance with the requirements of Sec. 2.948 of the FCC Rules. The descriptions and site measurement data of the Oakville 3-10 TDK Semi-Anechoic Chamber has been filed with ANAB File No.: AT-1945.

4.2. APPLICABILITY & SUMMARY OF EMC EMISSION TEST RESULTS

FCC Section(s)	Test Requirements	Compliance (Yes/No)
15.203	Antenna requirements	Yes
15.207(a)	AC Power Line Conducted Emissions	Yes
15.247(a)(2)	6 dB Bandwidth	Yes
15.247(b)(3)	Peak Conducted Output Power - DTS	Yes
15.247(d)	RF Conducted Spurious Emissions at the Transmitter Antenna Terminal	N/A
15.247(d), 15.209 & 15.205	Band-Edge and Transmitter Spurious Radiated Emissions and	Yes
15.247(e)	Power Spectral Density	Yes
15.247(i), 1.1307, 1.1310, 2.1091	RF Exposure	Yes

4.3. MODIFICATIONS INCORPORATED IN THE EUT FOR COMPLIANCE PURPOSES

None.

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EXHIBIT 5. TEST DATA

5.1. POWER LINE CONDUCTED EMISSIONS [§15.207(a)]

5.1.1. Limit(s)

The equipment shall meet the limits of the following table:

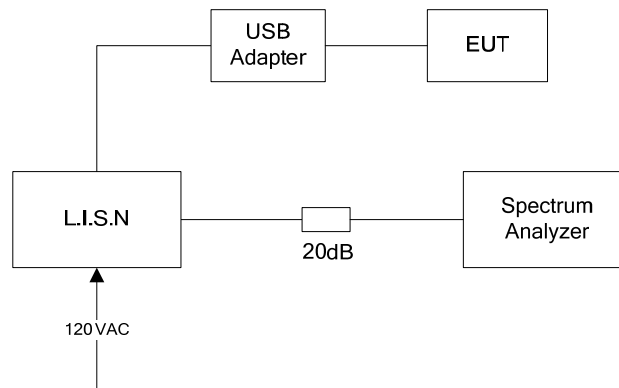
Frequency of emission (MHz)	Conducted Limits (dB μ V)	
	Quasi-peak	Average
0.15–0.5	66 to 56*	56 to 46*
0.5–5	56	46
5–30	60	50

*Decreases linearly with the logarithm of the frequency

5.1.2. Method of Measurements

ANSI C63.4

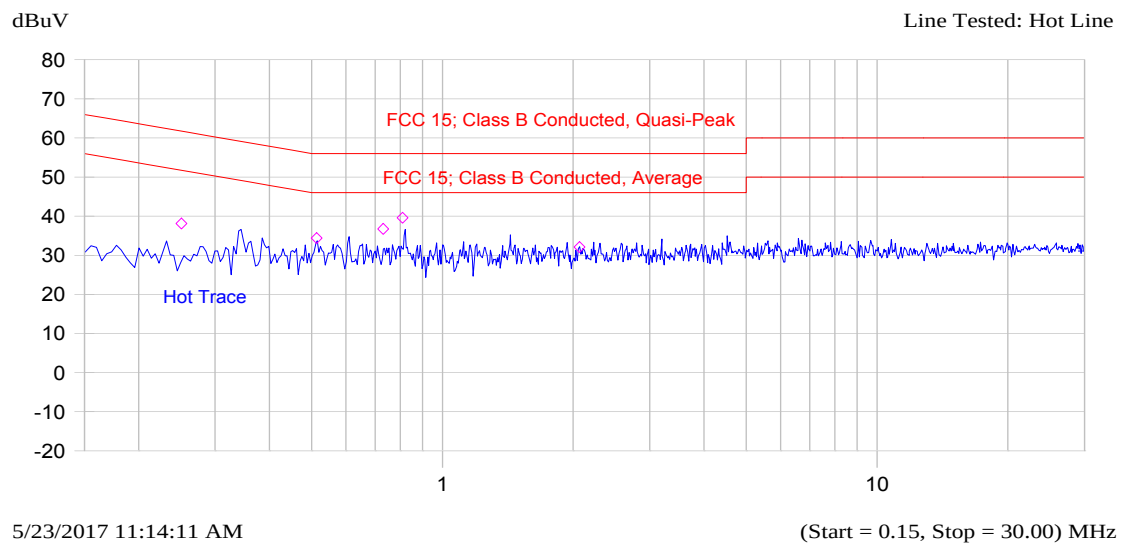
5.1.3. Test Arrangement



5.1.4. Test Data

Plot 5.1.4.1. Power Line Conducted Emissions
Line Voltage: 120 VAC; Line Tested: Hot

Current Graph

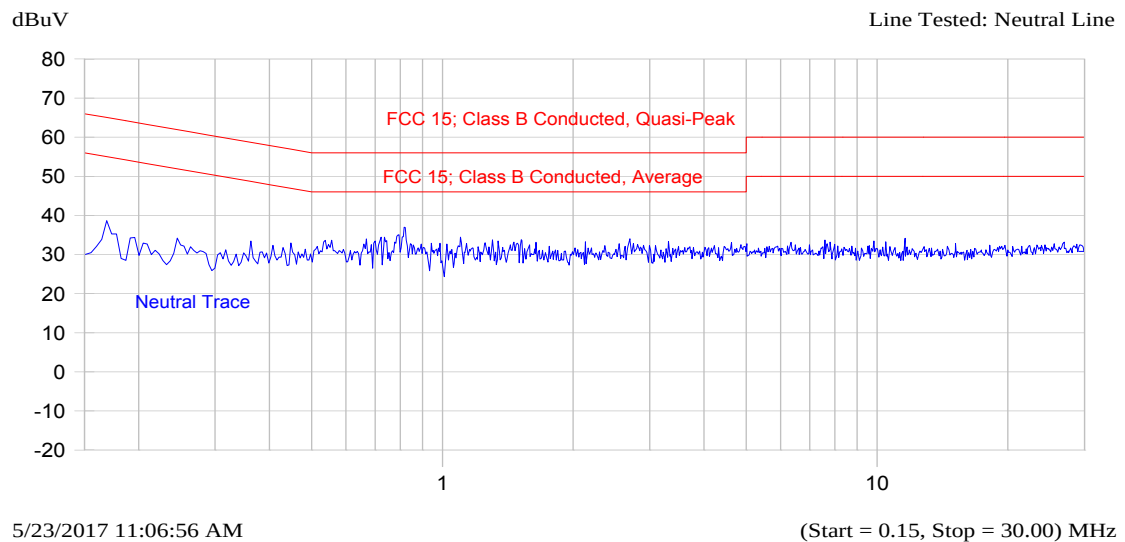


Current List

Frequency MHz	Peak dBuV	QP dBuV	QP-QP Limit dB	Avg dBuV	Avg-Avg Limit dB	Trace Name
0.251	38.1	29.6	-32.1	22.8	-28.9	Hot Trace
0.513	34.4	29.9	-26.1	23.5	-22.5	Hot Trace
0.730	36.7	29.5	-26.5	22.9	-23.1	Hot Trace
0.810	39.6	32.9	-23.1	25.0	-21.0	Hot Trace
2.067	32.1	27.0	-29.0	21.0	-25.0	Hot Trace

Plot 5.1.4.2. Power Line Conducted Emissions
Line Voltage: 120 VAC; Line Tested: Neutral

Current Graph



Current List

Frequency MHz	Peak dBuV	QP dBuV	QP-QP Limit dB	Avg dBuV	Avg-Avg Limit dB	Trace Name
0.167	39.0	31.6	-33.5	23.6	-31.5	Neutral Trace
0.811	36.8	31.6	-24.4	25.0	-21.0	Neutral Trace
1.099	33.1	28.0	-28.0	22.0	-24.0	Neutral Trace
1.528	32.7	27.6	-28.4	21.6	-24.4	Neutral Trace
11.594	29.8	24.9	-35.1	18.9	-31.1	Neutral Trace

5.2. OCCUPIED BANDWIDTH [§ 15.247(a)(2)]

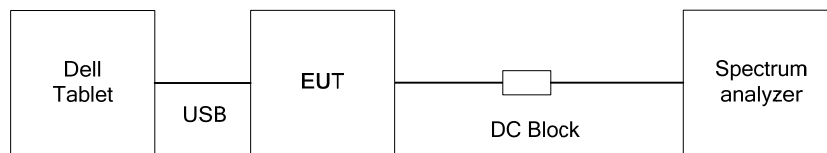
5.2.1. Limit(s)

The minimum 6 dB bandwidth shall be at least 500 kHz.

5.2.2. Method of Measurements

KDB 558074 D01 DTS Meas Guidance v04, Section 8.2 Option 2.

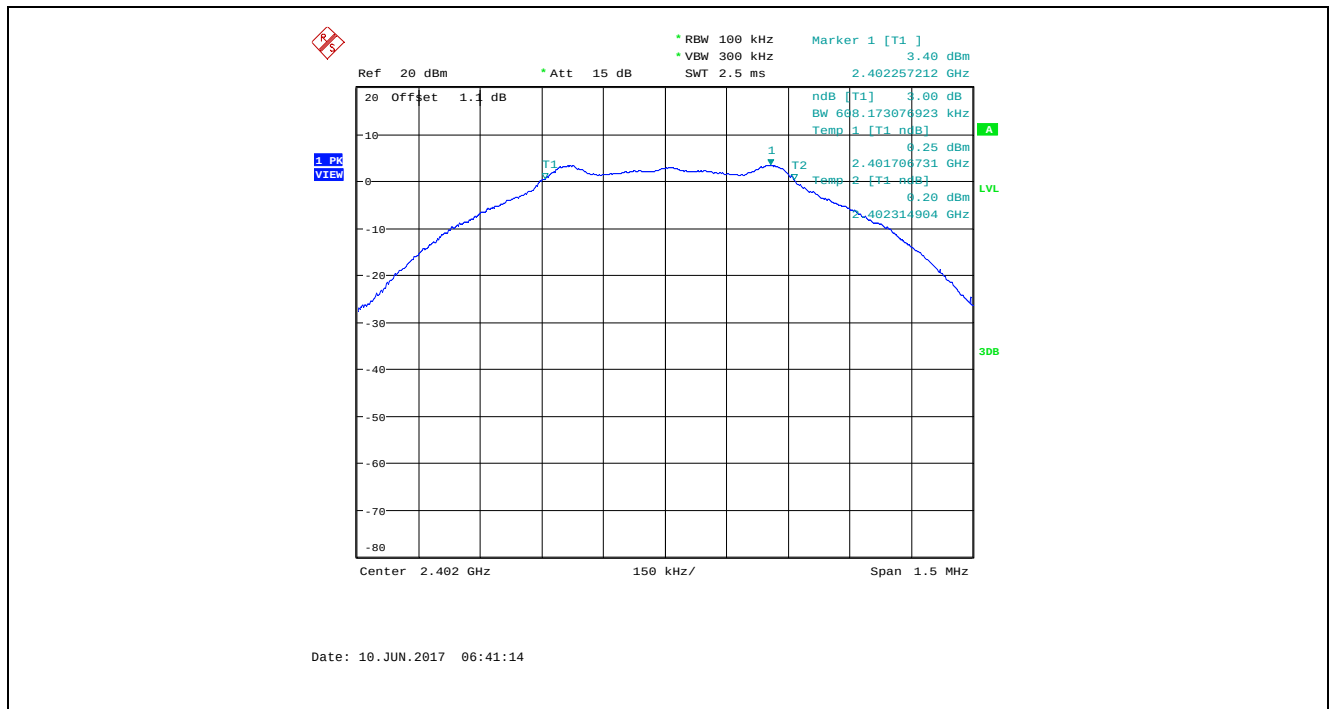
5.2.3. Test Arrangement



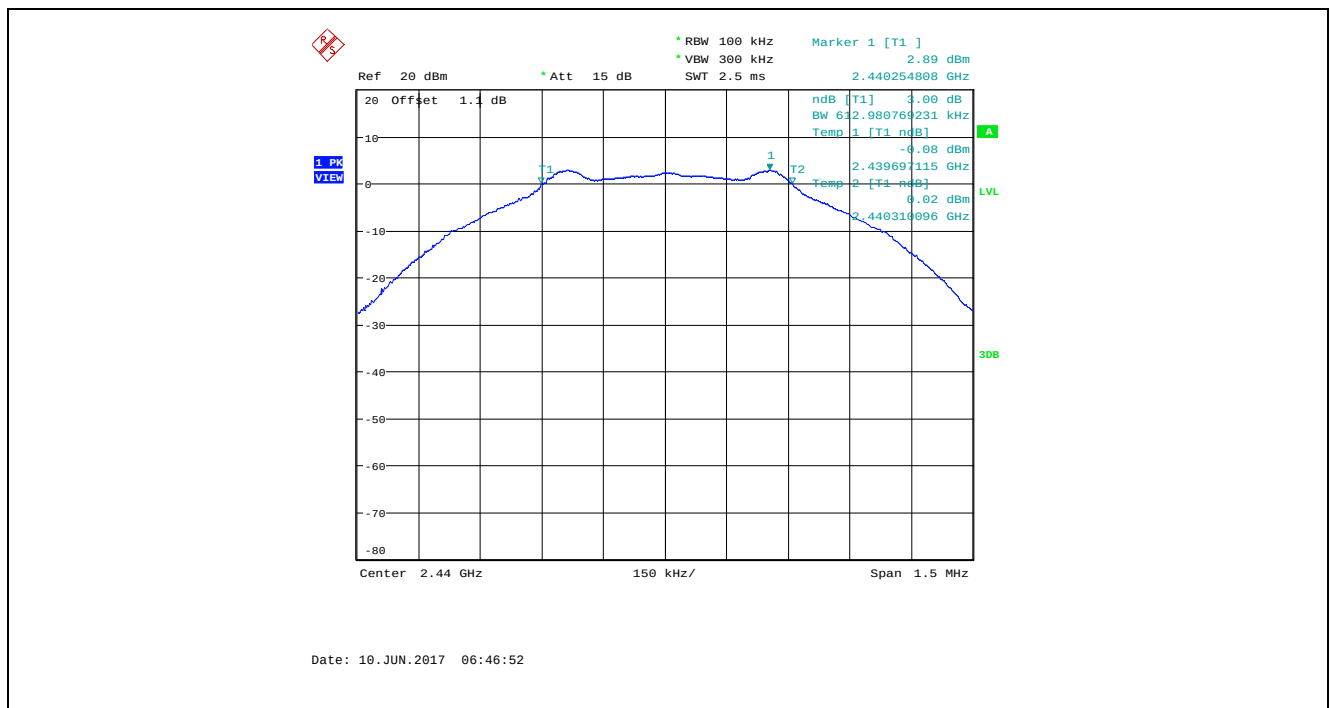
5.2.4. Test Data

Modulation	Frequency (MHz)	6dB BW (kHz)	Min. Limit (kHz)
GFSK	2402	608.17	500
	2440	612.98	500
	2480	612.98	500

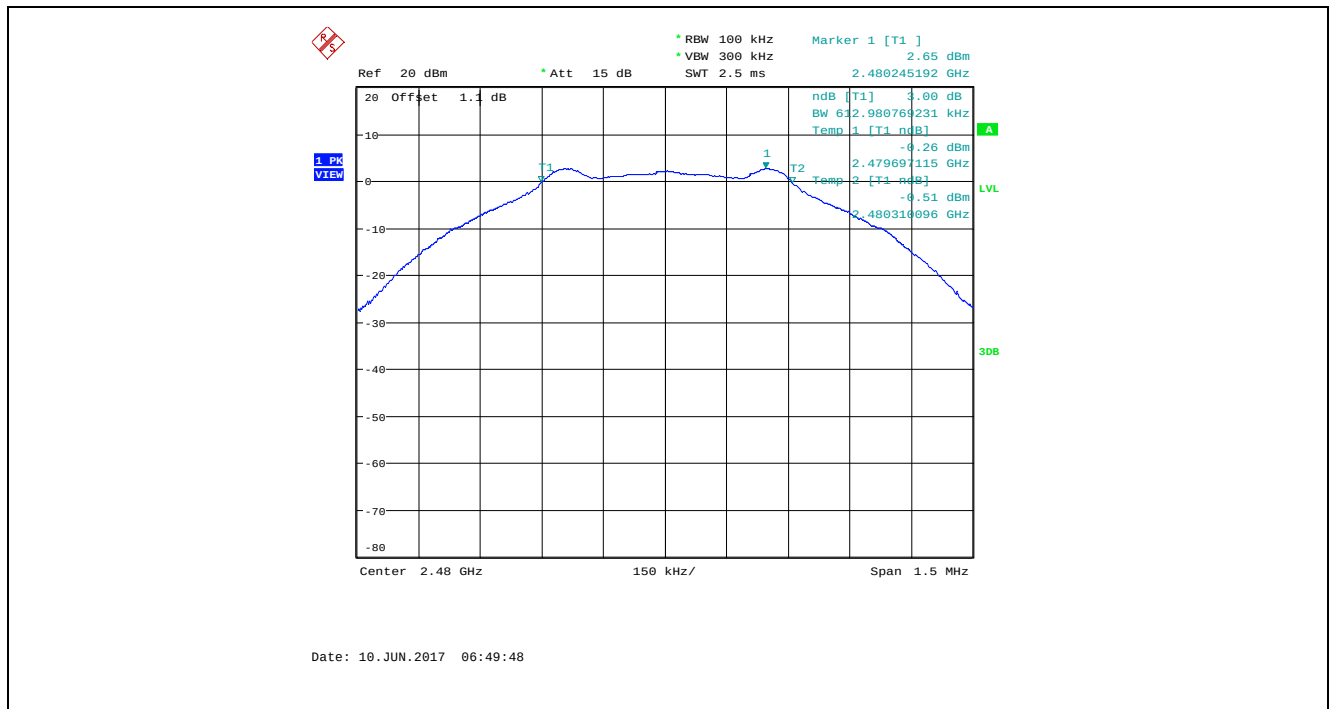
Plot 5.2.4.1. 6 dB Bandwidth, 2402 MHz



Plot 5.2.4.2. 6 dB Bandwidth, 2440 MHz



Plot 5.2.4.3. 6 dB Bandwidth, 2480 MHz



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5.3. PEAK CONDUCTED OUTPUT POWER - DTS [§ 15.247(b)(3)]

5.3.1. Limit(s)

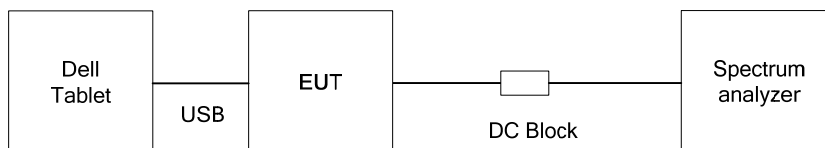
§ 15.247(b)(3): For systems using digital modulation in the 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz bands: 1 Watt. As an alternative to a peak power measurement, compliance with the one Watt limit can be based on a measurement of the maximum conducted output power. Maximum Conducted Output Power is defined as the total transmit power delivered to all antennas and antenna elements averaged across all symbols in the signaling alphabet when the transmitter is operating at its maximum power control level. Power must be summed across all antennas and antenna elements. The average must not include any time intervals during which the transmitter is off or is transmitting at a reduced power level. If multiple modes of operation are possible (e.g., alternative modulation methods), the *maximum conducted output power* is the highest total transmit power occurring in any mode.

§ 15.247(b)(4): The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

5.3.2. Method of Measurements & Test Arrangement

KDB 558074 D01 DTS Meas Guidance v04, Section 9.1.1 method RBW > DTS Bandwidth.

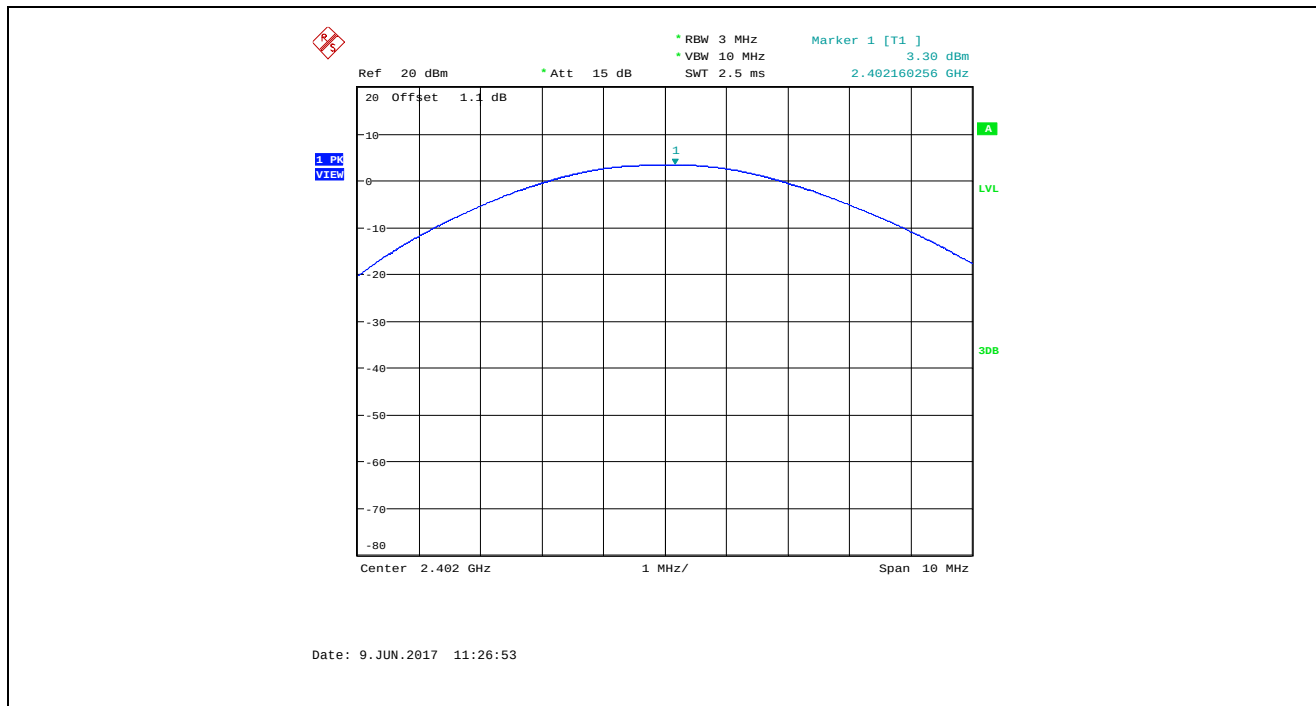
5.3.3. Test Arrangement



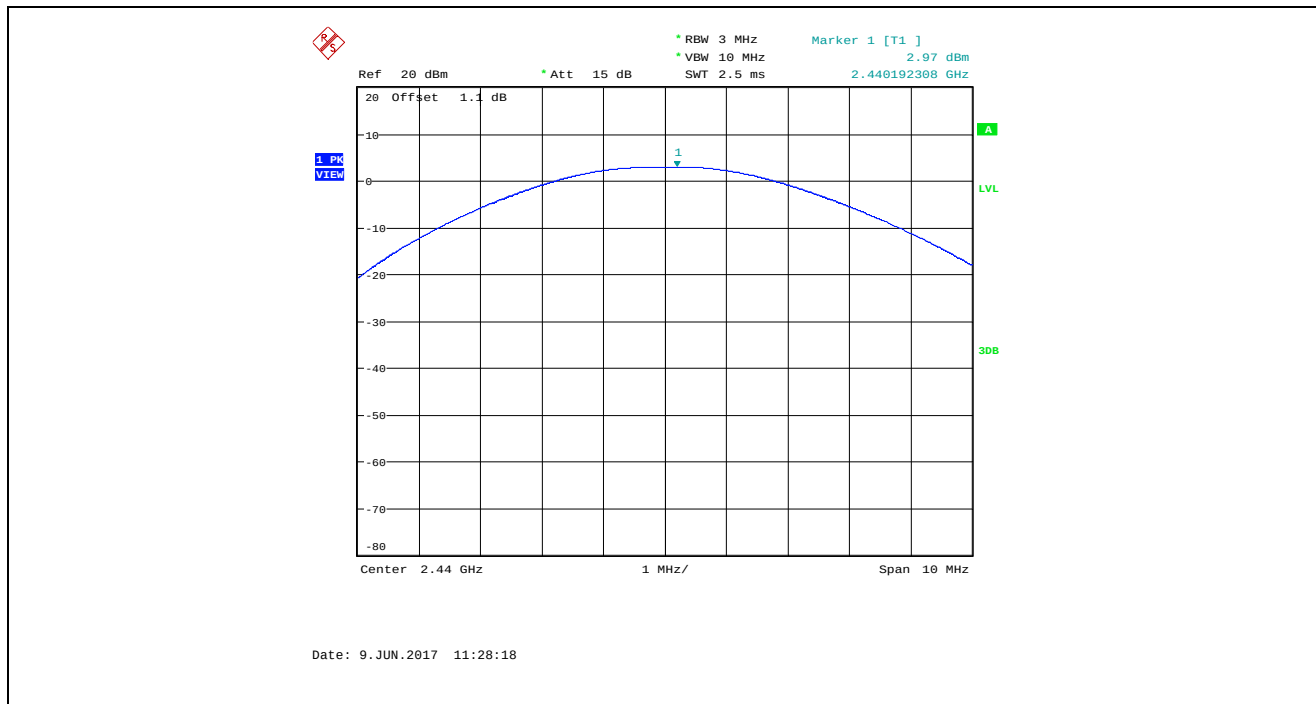
5.3.4. Test Data

Modulation	Frequency (MHz)	Peak Power (dBm)	Peak Power Limit (dBm)	Margin (dBm)
GFSK	2402	3.30	30	-26.70
	2440	2.97	30	-27.03
	2480	2.85	30	-27.15

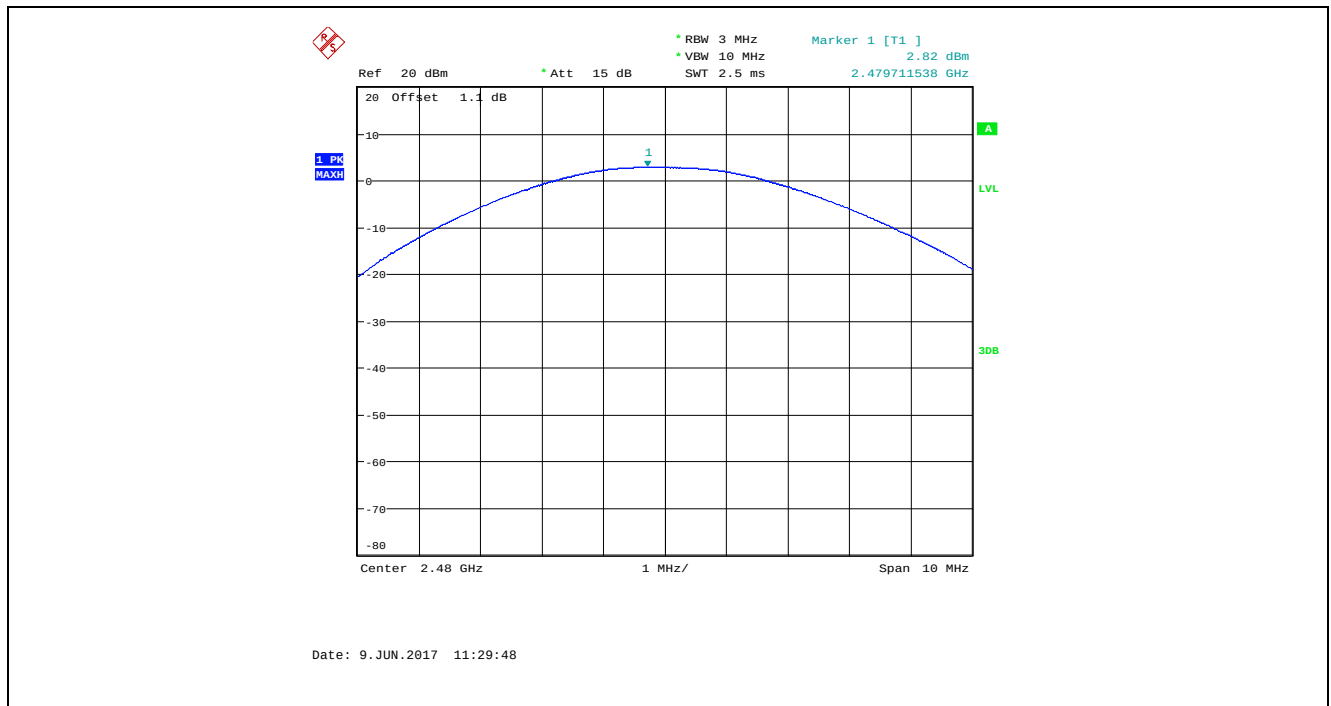
Plot 5.3.4.1. Maximum Peak Conducted Output Power, 2402 MHz



Plot 5.3.4.2. Maximum Peak Conducted Output Power, 2440 MHz



Plot 5.3.4.3. Maximum Peak Conducted Output Power, 2480 MHz



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5.4. TRANSMITTER SPURIOUS RADIATED EMISSIONS AT 3 METERS [§§ 15.247(d), 15.209 & 15.205]

5.4.1. Limit(s)

§ 15.247 (d): In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 15.205(c)).

Section 15.205(a) - Restricted Bands of Operation

MHz	MHz	MHz	GHz
0.090–0.110	16.42–16.423	399.9–410	4.5–5.15
¹ 0.495–0.505	16.69475–16.69525	608–614	5.35–5.46
2.1735–2.1905	16.80425–16.80475	960–1240	7.25–7.75
4.125–4.128	25.5–25.67	1300–1427	8.025–8.5
4.17725–4.17775	37.5–38.25	1435–1626.5	9.0–9.2
4.20725–4.20775	73–74.6	1645.5–1646.5	9.3–9.5
6.215–6.218	74.8–75.2	1660–1710	10.6–12.7
6.26775–6.26825	108–121.94	1718.8–1722.2	13.25–13.4
6.31175–6.31225	123–138	2200–2300	14.47–14.5
8.291–8.294	149.9–150.05	2310–2390	15.35–16.2
8.362–8.366	156.52475–156.52525	2483.5–2500	17.7–21.4
8.37625–8.38675	156.7–156.9	2655–2900	22.01–23.12
8.41425–8.41475	162.0125–167.17	3260–3267	23.6–24.0
12.29–12.293	167.72–173.2	3332–3339	31.2–31.8
12.51975–12.52025	240–285	3345.8–3358	36.43–36.5
12.57675–12.57725	322–335.4	3600–4400	(²)
13.36–13.41			

¹ Until February 1, 1999, this restricted band shall be 0.490–0.510 MHz.

² Above 38.6

Section 15.209(a) - Field Strength Limits within Restricted Frequency Bands

Frequency (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meters)
0.009 - 0.490	2,400 / F (kHz)	300
0.490 - 1.705	24,000 / F (kHz)	30
1.705 - 30.0	30	30
30 – 88	100	3
88 – 216	150	3
216 – 960	200	3
Above 960	500	3

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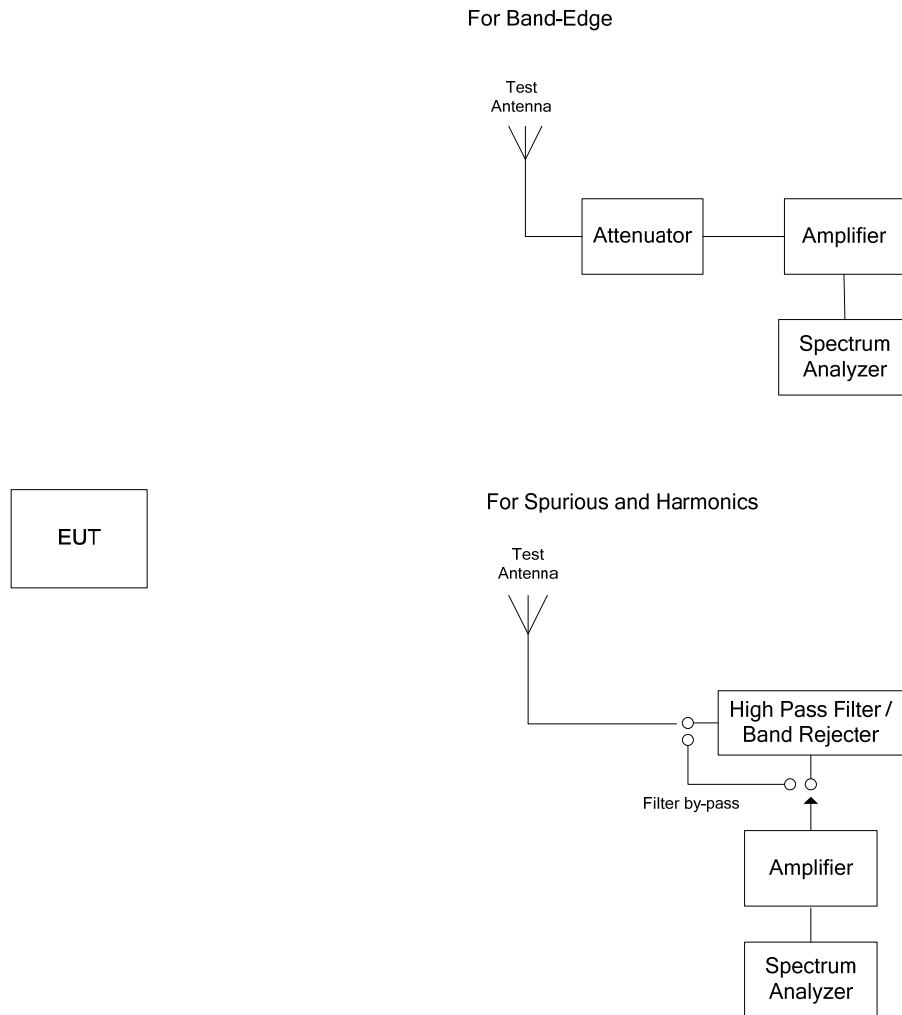
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5.4.2. Method of Measurements

FCC Public Notice DA 00-705, ANSI C63.10 and ANSI 63.4 procedures.

5.4.3. Test Arrangement



5.4.4. Test Data

Remark(s):

- All spurious emissions that are in excess of 20 dB below the specified limit shall be recorded.
- EUT shall be tested in three orthogonal positions.
- The following test data represent the worst-case derived from exploratory tests.

5.4.4.1. Spurious Radiated Emissions: EUT with 0 dBi integral Chip Antenna

Fundamental Frequency:		2402 MHz					
Frequency Test Range:		30 MHz – 25 GHz					
Frequency (MHz)	RF Peak Level (dBµV/m)	RF Avg Level (dBµV/m)	Antenna Plane (H/V)	Limit 15.209 (dBµV/m)	Limit 15.247 (dBµV/m)	Margin (dB)	Pass/Fail
2402	92.06	--	V	--	--	--	--
2402	90.80	--	H	--	--	--	--
4804	49.57	38.89	V	54.0	72.1	-15.1	Pass*
4804	49.49	40.15	H	54.0	72.1	-13.9	Pass*
All other spurious emissions and harmonics are more than 20 dB below the applicable limit.							

*Field strength of emissions appearing within restricted frequency bands shall not exceed the limits in § 15.209.

Fundamental Frequency:		2440 MHz					
Frequency Test Range:		30 MHz – 25 GHz					
Frequency (MHz)	RF Peak Level (dBµV/m)	RF Avg Level (dBµV/m)	Antenna Plane (H/V)	Limit 15.209 (dBµV/m)	Limit 15.247 (dBµV/m)	Margin (dB)	Pass/Fail
2440	92.04	--	V	--	--	--	--
2440	90.71	--	H	--	--	--	--
4880	50.06	41.21	V	54.0	72.0	-12.8	Pass*
4880	50.20	40.87	H	54.0	72.0	-13.1	Pass*
7320	50.63	35.96	V	54.0	72.0	-18.0	Pass*
7320	50.13	37.24	H	54.0	72.0	-16.8	Pass*
All other spurious emissions and harmonics are more than 20 dB below the applicable limit.							

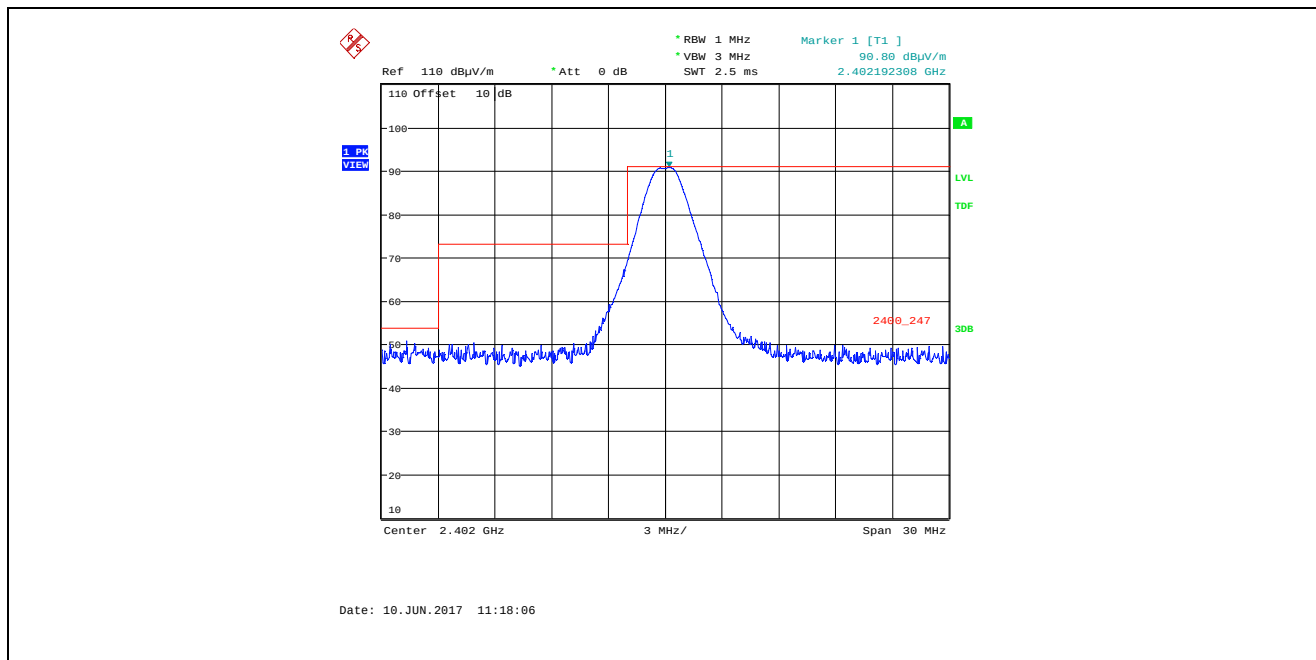
*Field strength of emissions appearing within restricted frequency bands shall not exceed the limits in § 15.209.

Fundamental Frequency:		2480 MHz					
Frequency Test Range:		30 MHz – 25 GHz					
Frequency (MHz)	RF Peak Level (dBµV/m)	RF Avg Level (dBµV/m)	Antenna Plane (H/V)	Limit 15.209 (dBµV/m)	Limit 15.247 (dBµV/m)	Margin (dB)	Pass/Fail
2480	92.12	--	V	--	--	--	--
2480	90.55	--	H	--	--	--	--
4960	50.12	41.78	V	54.0	72.1	-12.2	Pass*
4960	49.66	41.09	H	54.0	72.1	-12.9	Pass*
7440	50.40	36.79	V	54.0	72.1	-17.2	Pass*
7440	51.27	36.80	H	54.0	72.1	-17.2	Pass*
All other spurious emissions and harmonics are more than 20 dB below the applicable limit.							

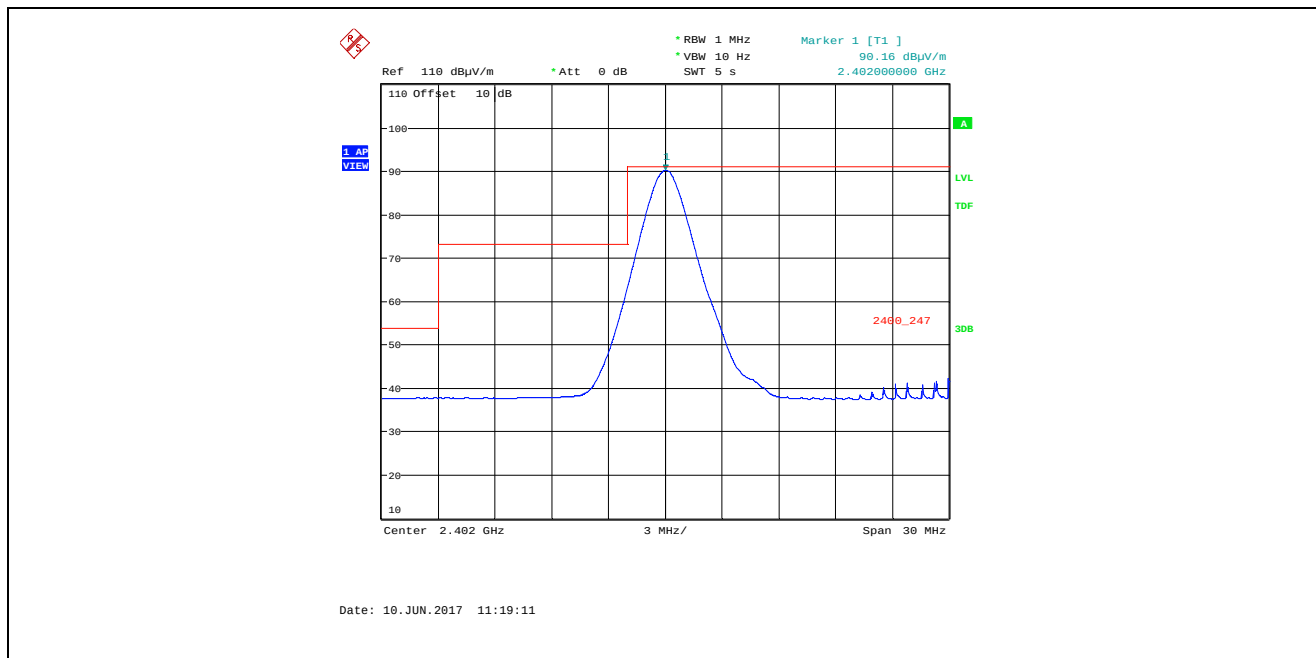
*Field strength of emissions appearing within restricted frequency bands shall not exceed the limits in § 15.209.

5.4.4.2. Band –Edge RF Radiated Emissions

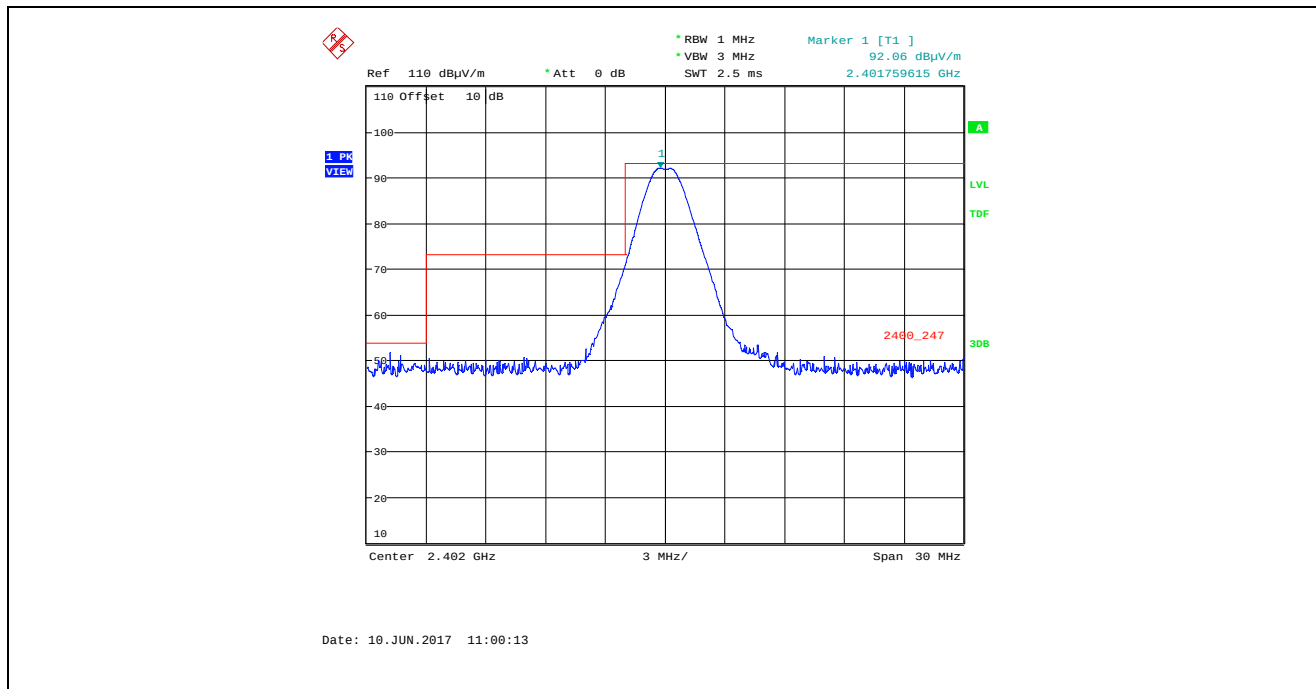
Plot 5.4.4.2.1. Band-Edge RF Radiated Emissions at 3 m, Horizontal Polarization
Lowest Frequency Channel, RBW = 1 MHz, VBW = 3 MHz



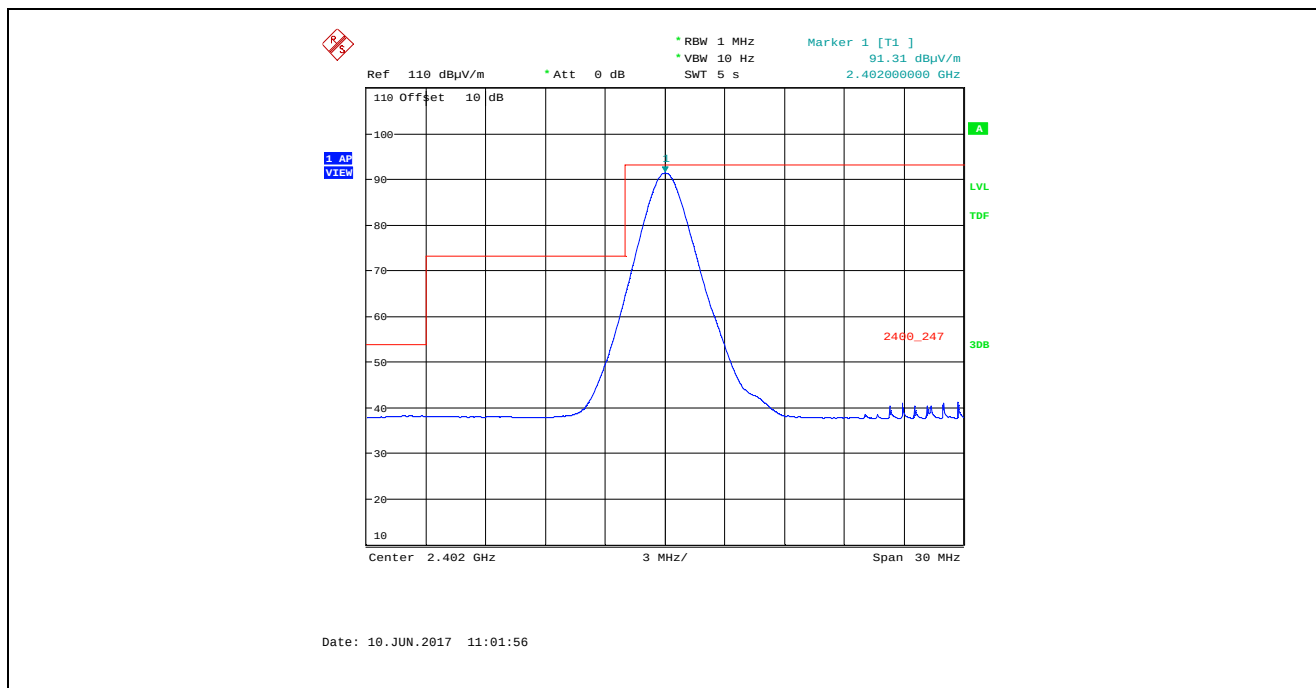
Plot 5.4.4.2.2. Band-Edge RF Radiated Emissions at 3 m, Horizontal Polarization
Lowest Frequency Channel, RBW = 1 MHz, VBW = 10 Hz



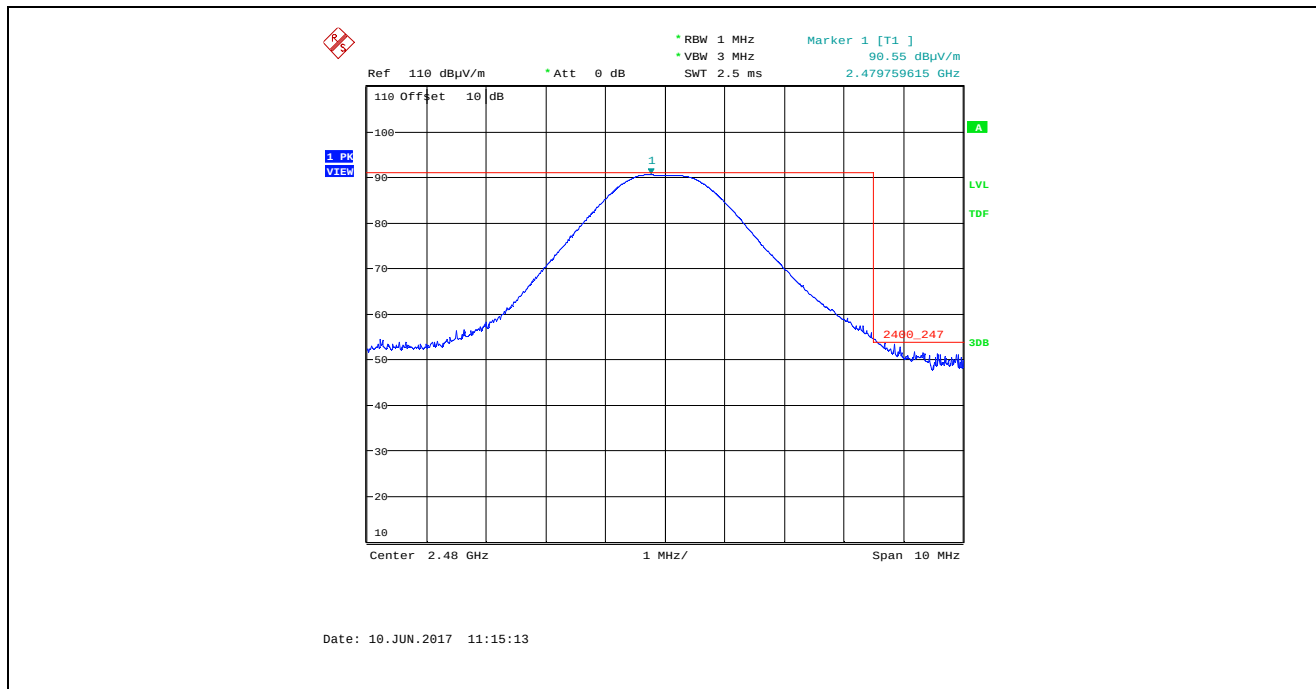
Plot 5.4.4.2.3. Band-Edge RF Radiated Emissions at 3 m, Vertical Polarization
Lowest Frequency Channel, RBW = 1 MHz, VBW = 3 MHz



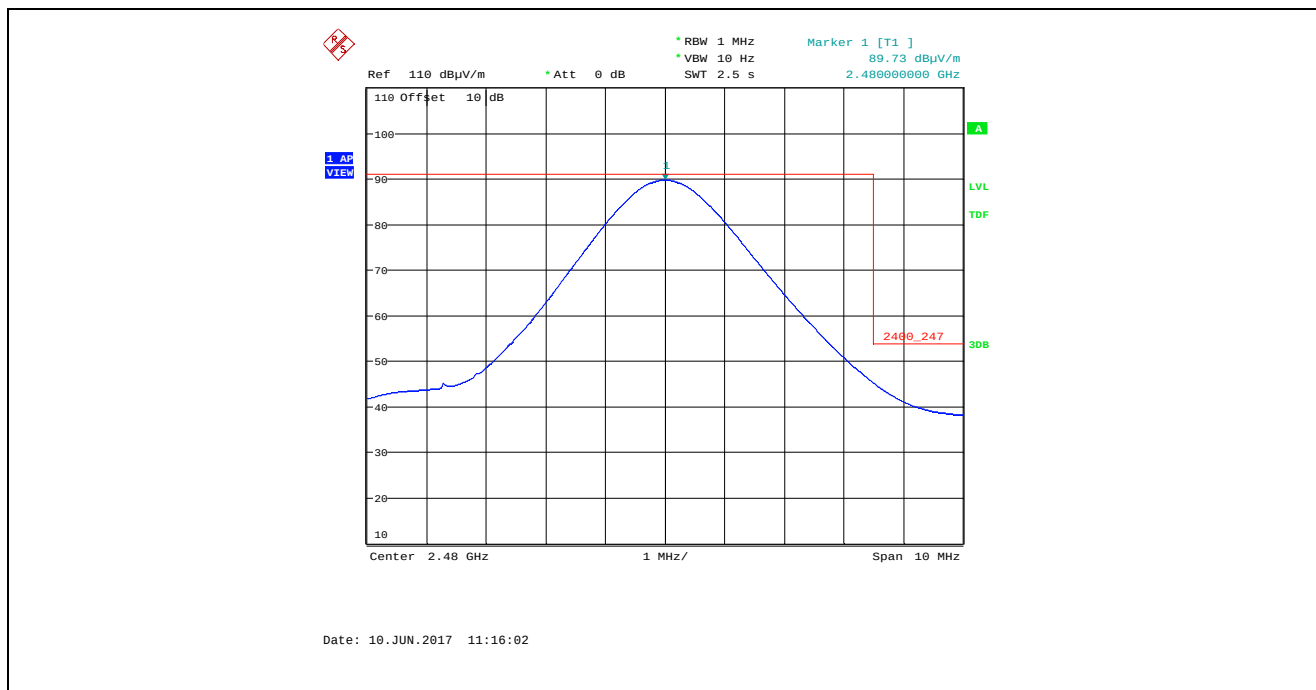
Plot 5.4.4.2.4. Band-Edge RF Radiated Emissions at 3 m, Vertical Polarization
Lowest Frequency Channel, RBW = 1 MHz, VBW = 10 Hz



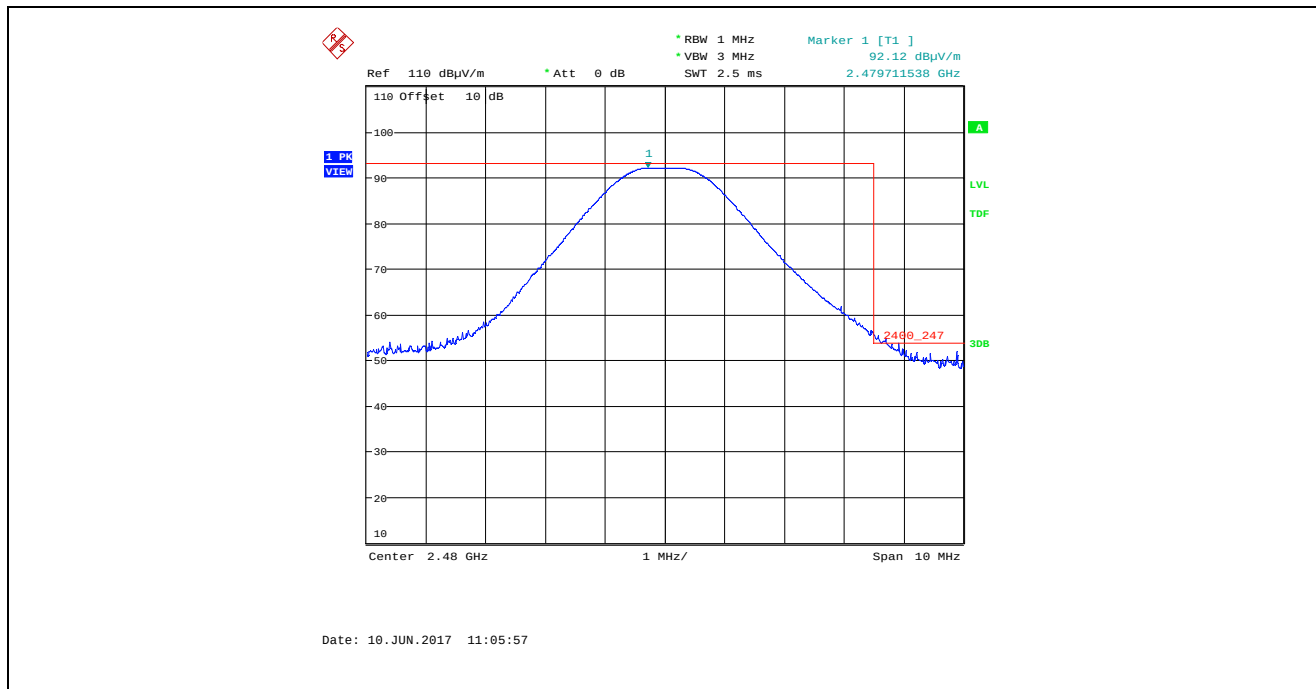
Plot 5.4.4.2.5. Band-Edge RF Radiated Emissions at 3 m, Horizontal Polarization
Highest Frequency Channel, RBW = 1 MHz, VBW = 3 MHz



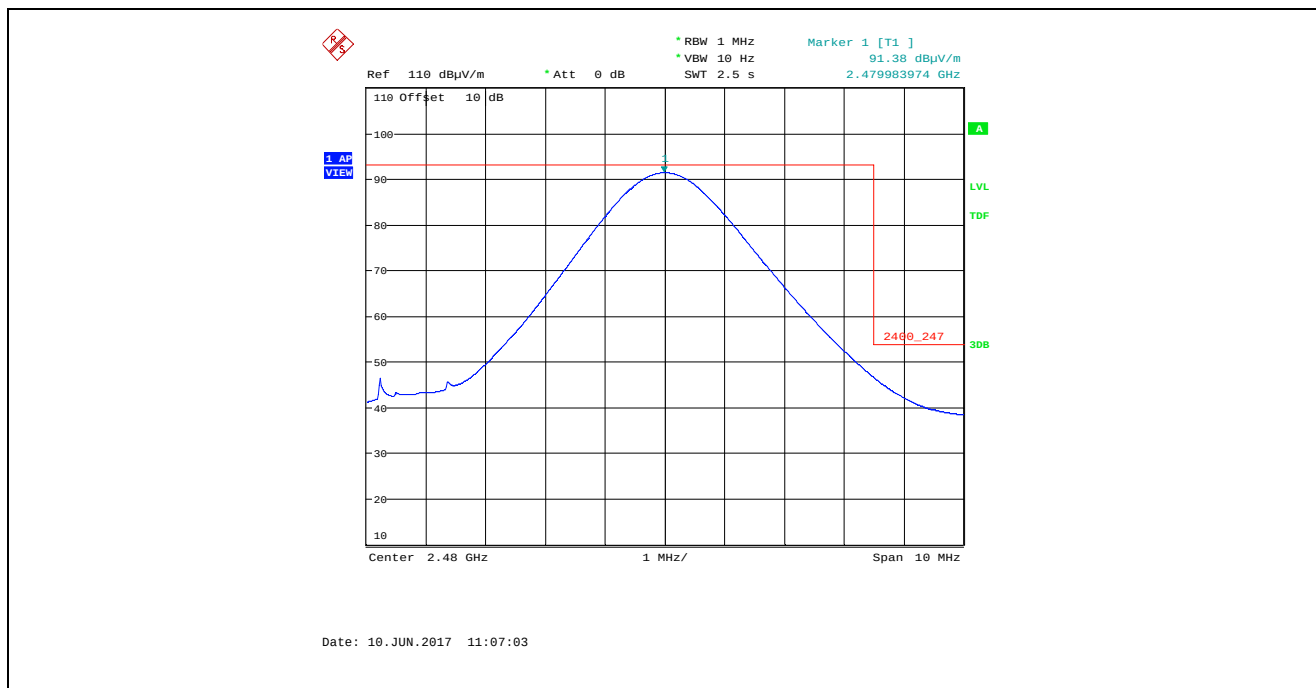
Plot 5.4.4.2.6. Band-Edge RF Radiated Emissions at 3 m, Horizontal Polarization
Highest Frequency Channel, RBW = 1 MHz, VBW = 10 Hz



Plot 5.4.4.2.7. Band-Edge RF Radiated Emissions at 3 m, Vertical Polarization
Highest Frequency Channel, RBW = 1 MHz, VBW = 3 MHz



Plot 5.4.4.2.8. Band-Edge RF Radiated Emissions at 3 m, Vertical Polarization
Highest Frequency Channel, RBW = 1 MHz, VBW = 10 Hz



5.5. POWER SPECTRAL DENSITY [§ 15.247(e)]

5.5.1. Limit(s)

For digitally modulated systems, the power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission.

5.5.2. Method of Measurements

KDB 558074 D01 DTS Meas Guidance v04, Section 10.2 Method PKPSD (peak PSD).

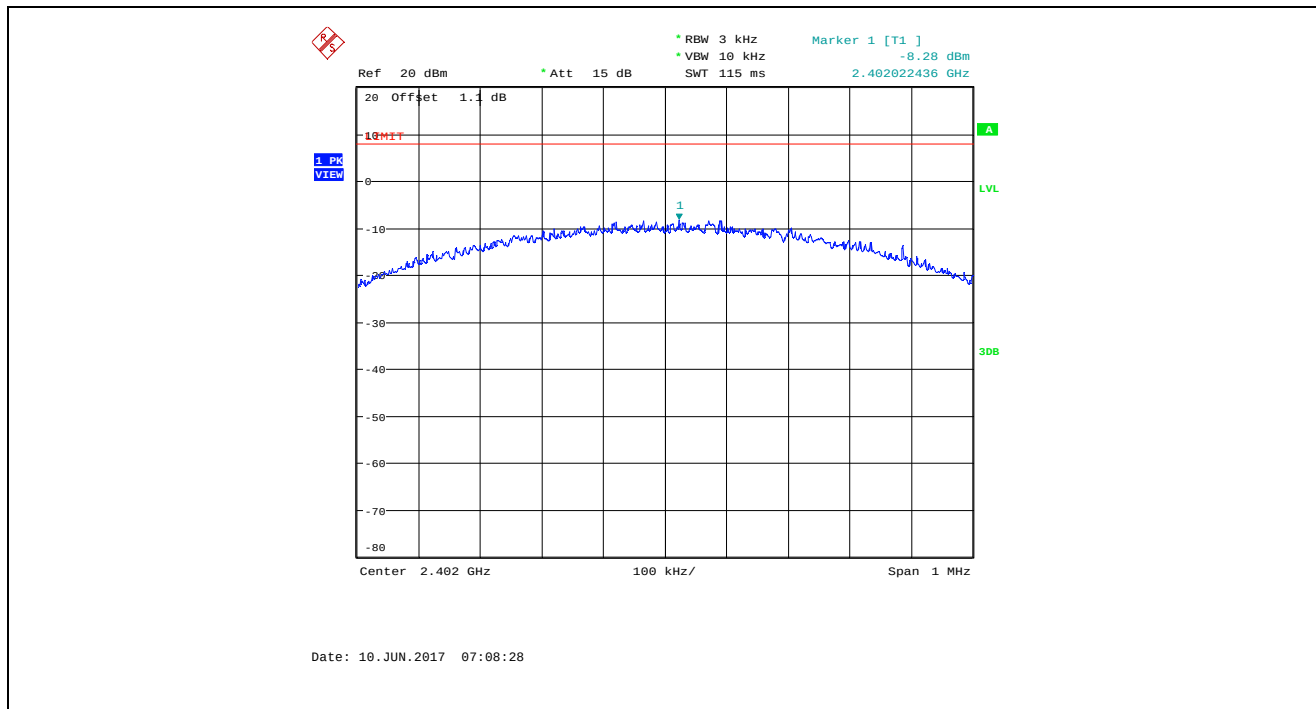
5.5.3. Test Arrangement



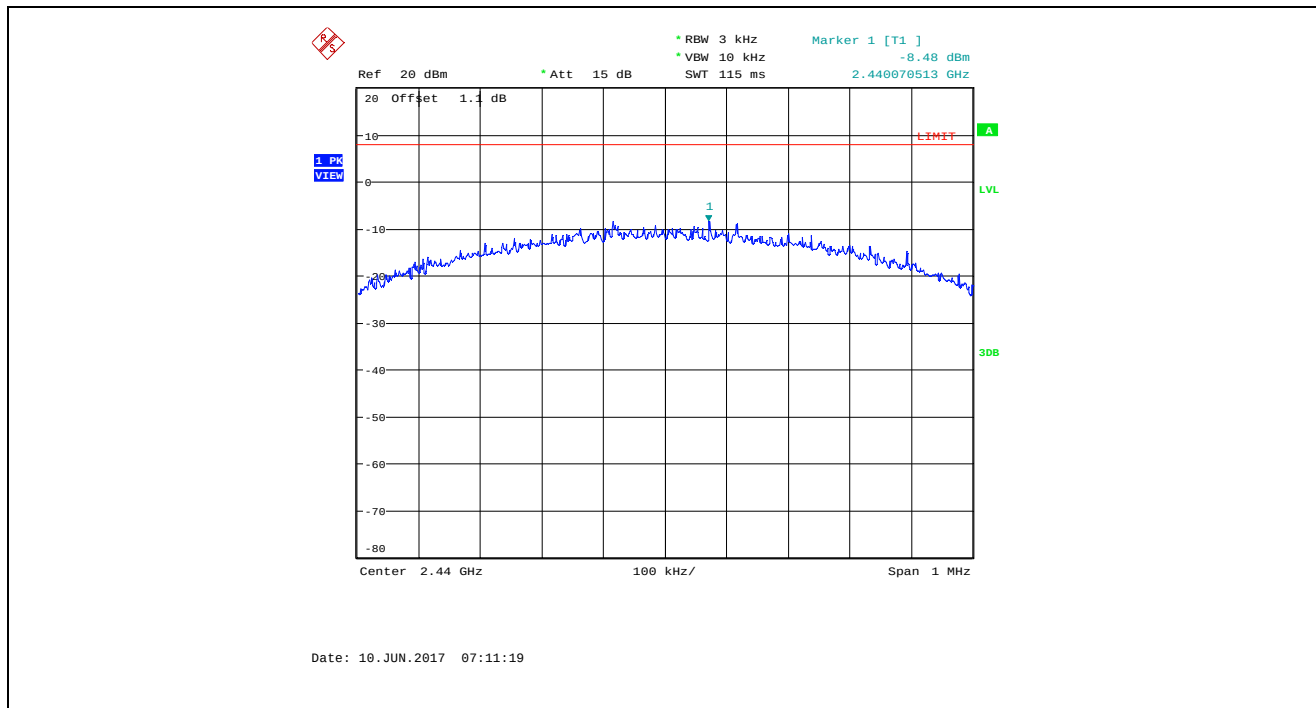
5.5.4. Test Data

Modulation	Frequency (MHz)	PSD (dBm)	Max. Limit (dBm)	Margin (dBm)
GFSK	2402	-8.28	8	-16.28
	2440	-8.48	8	-16.48
	2480	-9.32	8	-17.32

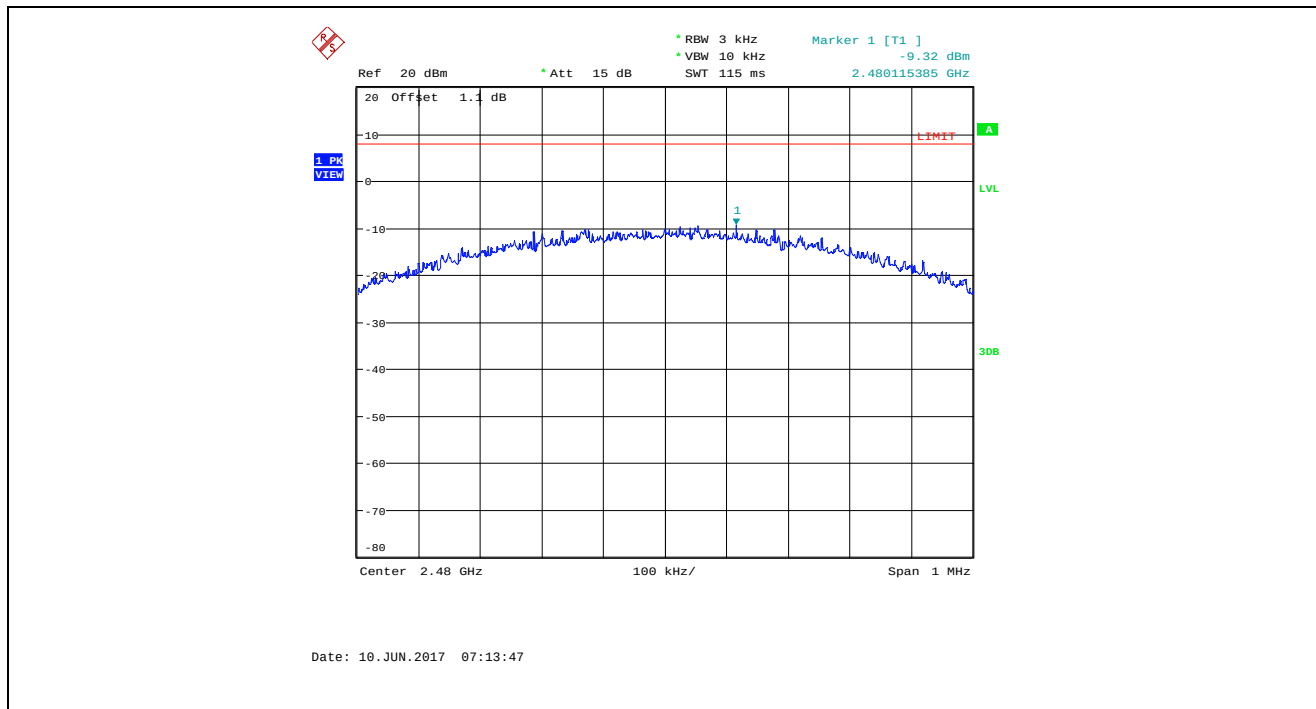
Plot 5.5.4.1. Power Spectral Density, 2402 MHz



Plot 5.5.4.2. Power Spectral Density, 2440 MHz



Plot 5.5.4.3. Power Spectral Density, Bandwidth 2480 MHz



5.6. RF EXPOSURE REQUIREMENTS [§§ 15.247(i), 1.1310 & 2.1091]

5.6.1. Limits

§ 1.1310: The criteria listed in the following table shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in 1.1307(b).

Limits for Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposures				
0.3-3.0	614	1.63	*(100)	6
3.0-30	1842/f	4.89/f	*(900/f ²)	6
30-300	61.4	0.163	1.0	6
300-1500			f/300	6
1500-100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*(100)	30
1.34-30	824/f	2.19/f	*(180/f ²)	30
30-300	27.5	0.073	0.2	30
300-1500			f/1500	30
1500-100,000			1.0	30

f = frequency in MHz

* = Plane-wave equivalent power density

Note 1: Occupational/controlled limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure. Limits for occupational/controlled exposure also apply in situations when an individual is transient through a location where occupational/controlled limits apply provided he or she is made aware of the potential for exposure.

Note 2: General population/uncontrolled exposures apply in situations in which the general public may be exposed, or in which persons that are exposed as a consequence of their employment may not be fully aware of the potential for exposure or can not exercise control over their exposure.

5.6.2. Method of Measurements

Calculation Method of Power Density/RF Safety Distance:

$$S = \frac{PG}{4\pi \cdot r^2} = \frac{EIRP}{4\pi \cdot r^2}$$

Where,
P: power input to the antenna in mW
EIRP: Equivalent (effective) isotropic radiated power.
S: power density mW/cm²
G: numeric gain of antenna relative to isotropic radiator
r: distance to centre of radiation in cm

5.6.3. RF Evaluation

For Portable Application				
Pursuant to FCC KDB 447498 D01 General RF Exposure Guidance v06, Section 4.3.1. Standalone SAR test exclusion considerations a) For 100 MHz to 6 GHz and test separation distances ≤ 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following: [(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] $\cdot [\sqrt{f(\text{GHz})}] \leq 3.0$ for 1-g SAR, and ≤ 7.5 for 10-g extremity SAR,30 where f(GHz) is the RF channel transmit frequency in GHz				
Max. power of channel, including tune-up tolerance, mW	Min. test separation distance, mm	f(GHz)	Calculated 1-g (head or boby) SAR test exclusion threshold	1-g (head or boby) SAR test exclusion threshold limit
2	2	2.402	1.5	3.0
Conclusion: The EUT qualify for SAR test exclusion at an evaluated separation distance of 2mm, the calculated 1-g SAR test exclusion threshold is $1.5 \leq 3.0$.				

EXHIBIT 6. TEST EQUIPMENT LIST

Test Instruments	Manufacturer	Model No.	Serial No.	Frequency Range	Cal. Due Date
Spectrum Analyzer	Rohde & Schwarz	FSU26	200946	20Hz–26.5 GHz	21 Jul 2018
DC Block	Hewlett Packard	11742A	12460	0.045 – 26.5 GHz	See Note 1
EMI Receiver	Rohde & Schwarz	ESU40	100037	20Hz–40 GHz	09 May 2018
Spectrum Analyzer	Rohde & Schwarz	FSU26	200946	20Hz–26.5 GHz	21 Jul 2018
RF Amplifier	Com-Power	PAM-0118A	551052	0.5 – 18 GHz	13 Jul 2017
RF Amplifier	Hewlett Packard	84498	3008A00769	1 – 26.5 GHz	01 May 2018
Biconilog	EMCO	3142	9601-1005	26-1000 MHz	12 May 2018
Horn Antenna	EMCO	3155	6570	1 – 18 GHz	13 Oct 2018
Horn Antenna	ETS-Lindgren	3160-09	001183858	18 – 26.5 GHz	11 Oct 2018
High Pass Filter	K & L	11SH10-4000/T12000	4	Cut off 2.4 GHz	See Note 1
Band Reject Filter	Micro-Tronics	BRM50701	105	Cut off 2.4-2.483 GHz	See Note 1
Attenuator	Pasternack	PE7024-10	4	DC–26.5 GHz	See Note 1
Spectrum Analyzer	Agilent	E7405A	US39440181	9 kHz – 26.5 GHz	04 Jan 2018
Attenuator	Pasternack	PE7010-20	07	DC – 2 GHz	13 Mar 2018
LISN	EMCO	3825/2	8907-1531	10 kHz – 100 MHz	11 Nov 2017
Note 1: Internal Verification/Calibration check					

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File #: 17NIX004_FCC15C247
July 14, 2017

All test results contained in this engineering test report are traceable to National Institute of Standards and Technology (NIST)

EXHIBIT 7. MEASUREMENT UNCERTAINTY

The measurement uncertainties stated were calculated in accordance with the requirements of CISPR 16-4-2 @ IEC:2003 and JCGM 100:2008 (GUM 1995) – Guide to the Expression of Uncertainty in Measurement.

7.1. LINE CONDUCTED EMISSION MEASUREMENT UNCERTAINTY

	Line Conducted Emission Measurement Uncertainty (9 kHz – 30 MHz):	Measured	Limit
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 1.44	± 1.8
U	Expanded uncertainty U: $U = 2u_c(y)$	± 2.89	± 3.6

7.2. RADIATED EMISSION MEASUREMENT UNCERTAINTY

	Radiated Emission Measurement Uncertainty @ 3m, Horizontal (30-1000 MHz):	Measured (dB)	Limit (dB)
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 2.39	± 2.6
U	Expanded uncertainty U: $U = 2u_c(y)$	± 4.79	± 5.2

	Radiated Emission Measurement Uncertainty @ 3m, Vertical (30-1000 MHz):	Measured (dB)	Limit (dB)
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 2.39	± 2.6
U	Expanded uncertainty U: $U = 2u_c(y)$	± 4.78	± 5.2

	Radiated Emission Measurement Uncertainty @ 3 m, Horizontal & Vertical (1 – 18 GHz):	Measured (dB)	Limit (dB)
u_c	Combined standard uncertainty: $u_c(y) = \sqrt{\sum_{i=1}^m u_i^2(y)}$	± 1.87	Under consideration
U	Expanded uncertainty U: $U = 2u_c(y)$	± 3.75	Under consideration